

# FDS7088SN3

# 30V N-Channel PowerTrench® SyncFET™

### **General Description**

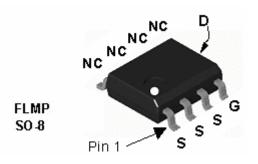
The FDS7088SN3 is designed to replace a single SO-8 FLMP MOSFET and Schottky diode in synchronous DC:DC power supplies. This 30V MOSFET is designed to maximize power conversion efficiency, providing a low  $R_{\rm DS(ON)}$  and low gate charge. The FDS7088SN3 includes an integrated Schottky diode using Fairchild's monolithic SyncFET technology. The performance of the FDS7088SN3 as the low-side switch in a synchronous rectifier is close to the performance of the FDS7088N3 in parallel with a Schottky diode.

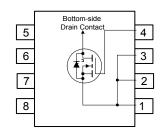
### **Applications**

- DC/DC converter
- Motor drives

### **Features**

- 21 A, 30 V  $R_{DS(ON)} = 4.0 \text{ m}\Omega$  @  $V_{GS} = 10 \text{ V}$  $R_{DS(ON)} = 4.9 \text{ m}\Omega$  @  $V_{GS} = 4.5 \text{ V}$
- High performance trench technology for extremely low  $R_{\mbox{\scriptsize DS(ON)}}$
- · High power and current handling capability
- · Fast switching
- FLMP SO-8 package: Enhanced thermal performance in industry-standard package size





### Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		30	V
V <sub>GSS</sub>	Gate-Source Voltage		±20	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	21	А
	– Pulsed		60	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	3.0	W
		(Note 1b)	1.7	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperat	ture Range	–55 to +150	°C

### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	40	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	0.5	°C/W

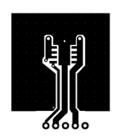
**Package Marking and Ordering Information** 

Device Marking	Device	Reel Size	Tape width	Quantity
FDS7088SN3	FDS7088SN3	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics		•			
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	30			٧
ΔBV <sub>DSS</sub> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 15 mA, Referenced to 25°C		28		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			500	μΑ
GSS	Gate-Body Leakage	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V			±100	nA
On Char	acteristics (Note 2)				•	
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 1$ mA	1	1.5	3	V
$\Delta V_{GS(th)}$ $\Delta T_{,J}$	Gate Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 15 mA, Referenced to 25°C		-3		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V}, \ I_D = 21 \text{ A}$ $V_{GS} = 4.5 \text{ V}, \ I_D = 19 \text{ A}$ $V_{GS} = 10 \text{ V}, \ I_D = 21 \text{ A}, \ T_J = 125^{\circ}\text{C}$		3.4 4.0 5	4.0 4.9	mΩ
<b>g</b> <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 21 A		85		S
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 \text{ V},  V_{GS} = 0 \text{ V},$		3230		pF
Coss	Output Capacitance	f = 1.0 MHz		890		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			300		pF
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> = 15 mV, f = 1.0 MHz		1.6		Ω
Switchin	g Characteristics (Note 2)					
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 15 \text{ V},  I_{D} = 1 \text{ A},$		20	32	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$		21	34	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	1		45	72	ns
t <sub>f</sub>	Turn-Off Fall Time	1		33	53	ns
$Q_{g(TOT)}$	Total Gate Charge at V <sub>GS</sub> =10V	$V_{DD} = 15 \text{ V},  I_{D} = 10 \text{ A}$		57	80	nC
$Q_g$	Total Gate Charge	$V_{DD} = 15 \text{ V},  I_{D} = 10 \text{ A}$ $V_{DD} = 15 \text{ V},  I_{D} = 10 \text{ A}$		31	44	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 5 V		8		nC
Q <sub>gd</sub>	Gate-Drain Charge			10		nC
Drain-Sc	ource Diode Characteristics	and Maximum Ratings				
I <sub>S</sub>	1	ce Schottky Diode Forward Current			4.3	Α
V <sub>SD</sub>	Drain–Source Schottky Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 4.3 A (Note 2)		0.4	0.7	V
t <sub>RR</sub>	Reverse Recovery Time	I <sub>F</sub> = 21 A		28		ns
$Q_{RR}$	Reverse Recovery Charge	diF/dt = 300 A/us		29		nC

### Notes:

1. R<sub>0JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



a) 40°C/W when mounted on a 1in² pad of 2 oz copper



85°C/W when mounted on a minimum pad of 2 oz copper

Scale 1 : 1 on letter size paper

**2.** Pulse Test: Pulse Width <  $300\mu$ s, Duty Cycle < 2.0%

### **Typical Characteristics**

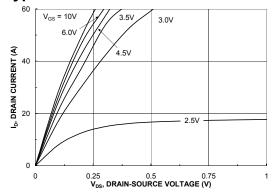


Figure 1. On-Region Characteristics.

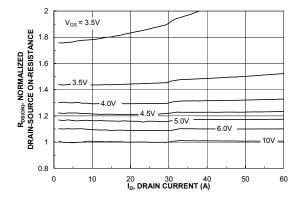


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

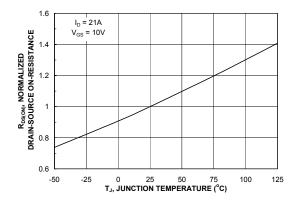


Figure 3. On-Resistance Variation withTemperature.

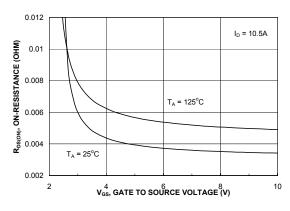


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

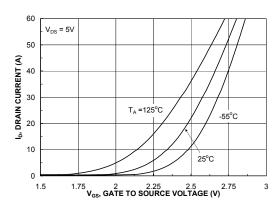


Figure 5. Transfer Characteristics.

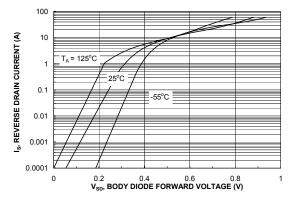


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

# **Typical Characteristics**

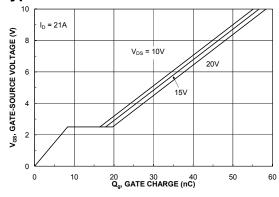
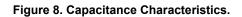
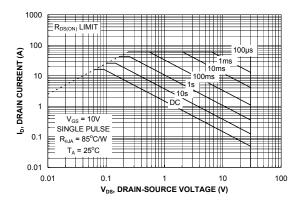


Figure 7. Gate Charge Characteristics.





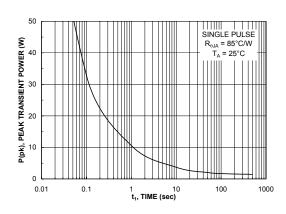


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

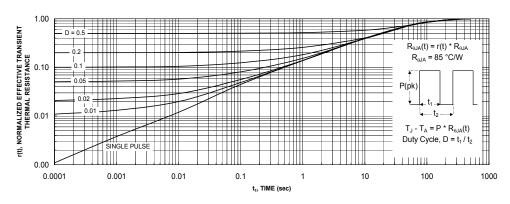


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

### Typical Characteristics (continued)

# SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 12 shows the reverse recovery characteristic of the FDS7088SN3.

0.08A/div

12.5 nS/div

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

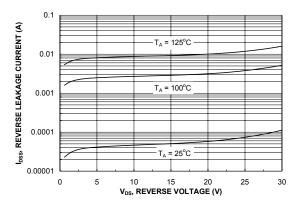


Figure 14. SyncFET body diode reverse leakage versus drain-source voltage and temperature

Figure 12. FDS7088SN3 SyncFET body diode reverse recovery characteristic.

For comparison purposes, Figure 13 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDS7088N3).

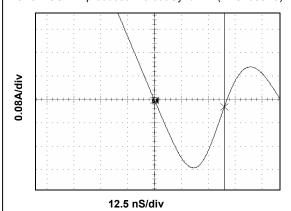
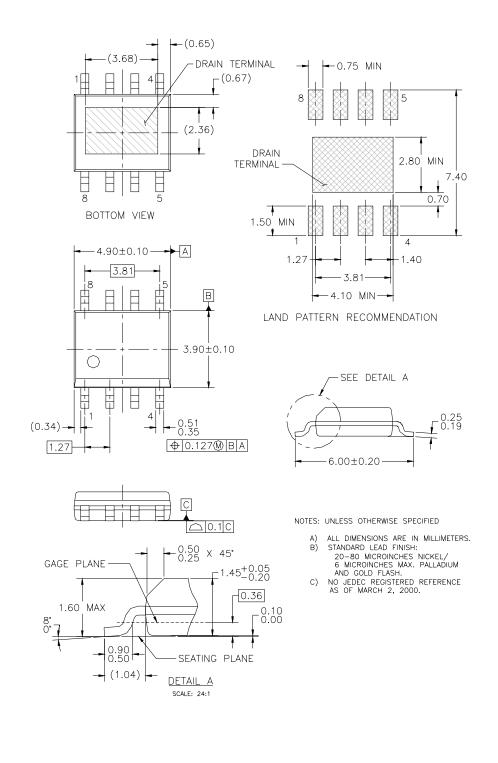


Figure 13. Non-SyncFET (FDS7088N3) body diode reverse recovery characteristic.

## **Dimensional Outline and Pad Layout**



### **TRADEMARKS**

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

$ACEx^{TM}$	FAST®	ISOPLANAR™	Power247™	SuperFET™
ActiveArray™	FASTr™	LittleFET™	PowerSaver™	SuperSOT™-3
Bottomless™	FPS™	$MICROCOUPLER^{TM}$	PowerTrench®	SuperSOT™-6
CoolFET™	FRFET™	MicroFET™	QFET®	SuperSOT™-8
$CROSSVOLT^{\text{TM}}$	GlobalOptoisolator™	MicroPak™	$QS^{TM}$	SyncFET™
DOME™	GTO™ .	MICROWIRE™	QT Optoelectronics™	TinyLogic <sup>®</sup>
EcoSPARK™	HiSeC™	MSX <sup>TM</sup>	Quiet Series™	TINYOPTO™
E <sup>2</sup> CMOS <sup>TM</sup>	I <sup>2</sup> C <sup>TM</sup>	MSXPro™	RapidConfigure™	TruTranslation™
EnSigna™	<i>i-</i> Lo <sup>™</sup>	$OCX^{TM}$	RapidConnect™	UHC™
FACT™	ImpliedDisconnect™	OCXPro™	μSerDes™	UltraFET®
FACT Quiet Serie	es <sup>™</sup>	OPTOLOGIC®	SILENT SWITCHER®	VCX <sup>TM</sup>
Across the board	d. Around the world.™	OPTOPLANAR™	SMART START™	
The Power France		PACMAN™	SPM <sup>TM</sup>	
			<u> </u>	

#### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

POPTM

#### LIFE SUPPORT POLICY

 $Programmable \ Active \ Droop^{\tiny\mathsf{TM}}$ 

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

Stealth™

#### PRODUCT STATUS DEFINITIONS

#### **Definition of Terms**

Datasheet Identification	Product Status	Definition	
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.	
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.	
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.	
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.	

Rev. I11